

| | | | | |
|-----------------------------------|--|---------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination CUDD ET AL. | |
| | | Examiner BENJAMIN O. DULANEY | Art Unit 2625 | Page 1 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-5,918,002 A | 06-1999 | Klemets et al. | 714/18 |
| * | B | US-5,959,630 A | 09-1999 | Takeuchi et al. | 715/835 |
| * | C | US-2001/0049703 A1 | 12-2001 | Miyoshi et al. | 707/527 |
| * | D | US-2002/0036662 A1 | 03-2002 | Gauthier et al. | 345/835 |
| * | E | US-2002/0046238 A1 | 04-2002 | Estavillo et al. | 709/203 |
| * | F | US-2002/0070961 A1 | 06-2002 | Xu et al. | 345/738 |
| * | G | US-2002/0109680 A1 | 08-2002 | Orbanes et al. | 345/418 |
| * | H | US-2002/0143814 A1 | 10-2002 | Hepworth et al. | 707/512 |
| * | I | US-2002/0194081 A1 | 12-2002 | Perkowski, Thomas J. | 705/26 |
| * | J | US-2002/0198720 A1 | 12-2002 | Takagi et al. | 704/270.1 |
| * | K | US-2003/0058469 A1 | 03-2003 | Buis et al. | 358/1.15 |
| * | L | US-2003/0055876 A1 | 03-2003 | Korala et al. | 709/203 |
| * | M | US-2003/0050893 A1 | 03-2003 | Hirabayashi, Shinji | 705/52 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. 10/668,273 | Applicant(s)/Patent Under Reexamination CUDD ET AL. | |
| | | Examiner BENJAMIN O. DULANEY | Art Unit 2625 | Page 2 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------------|----------------|
| * | A | US-2003/0053102 A1 | 03-2003 | Kelsey, Todd Mark | 358/1.13 |
| * | B | US-2003/0058277 A1 | 03-2003 | BOWMAN-AMUAH, MICHEL K. | 345/765 |
| * | C | US-2003/0158957 A1 | 08-2003 | Abdolsalehi, Ali | 709/231 |
| * | D | US-6,636,863 B1 | 10-2003 | Friesen, E. Lane | 707/102 |
| * | E | US-2004/0021679 A1 | 02-2004 | Chapman et al. | 345/700 |
| * | F | US-6,765,691 B2 | 07-2004 | Kubo et al. | 358/1.9 |
| * | G | US-6,801,224 B1 | 10-2004 | Lewallen, Stephen Richard | 715/746 |
| * | H | US-2004/0201613 A1 | 10-2004 | Simpson et al. | 345/738 |
| * | I | US-2004/0205633 A1 | 10-2004 | Martinez et al. | 715/526 |
| * | J | US-2005/0010093 A1 | 01-2005 | Ford et al. | 600/345 |
| * | K | US-6,978,445 B2 | 12-2005 | Laane, Lisa Ann | 717/131 |
| * | L | US-7,020,697 B1 | 03-2006 | Goodman et al. | 709/223 |
| * | M | US-7,047,033 B2 | 05-2006 | Wyler, Eran Shmuel | 455/552.1 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | | |
|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. 10/668,273 | Applicant(s)/Patent Under Reexamination CUDD ET AL. | |
| | | Examiner BENJAMIN O. DULANEY | Art Unit 2625 | Page 3 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------|----------------|
| * | A | US-7,263,659 B2 | 08-2007 | Hull et al. | 715/716 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.